

## Appendix C – SAR Test Setup Photos



**Test Position Side A 0 mm Gap**



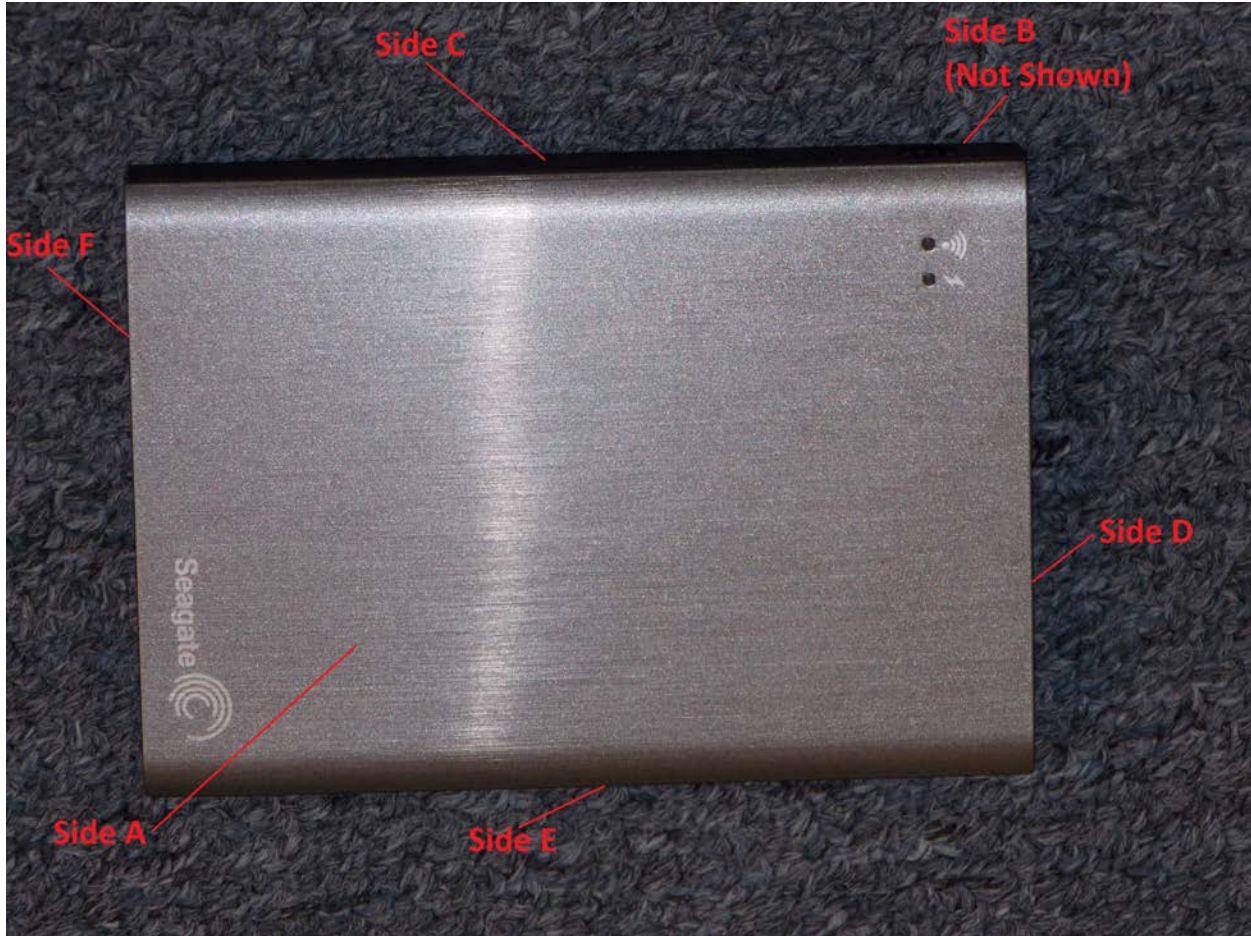
**Test Position Side B 0 mm Gap**



**Test Position Side C 0 mm Gap**



**Test Position Side D 0 mm Gap**



**Front of Device and Testing Locations**

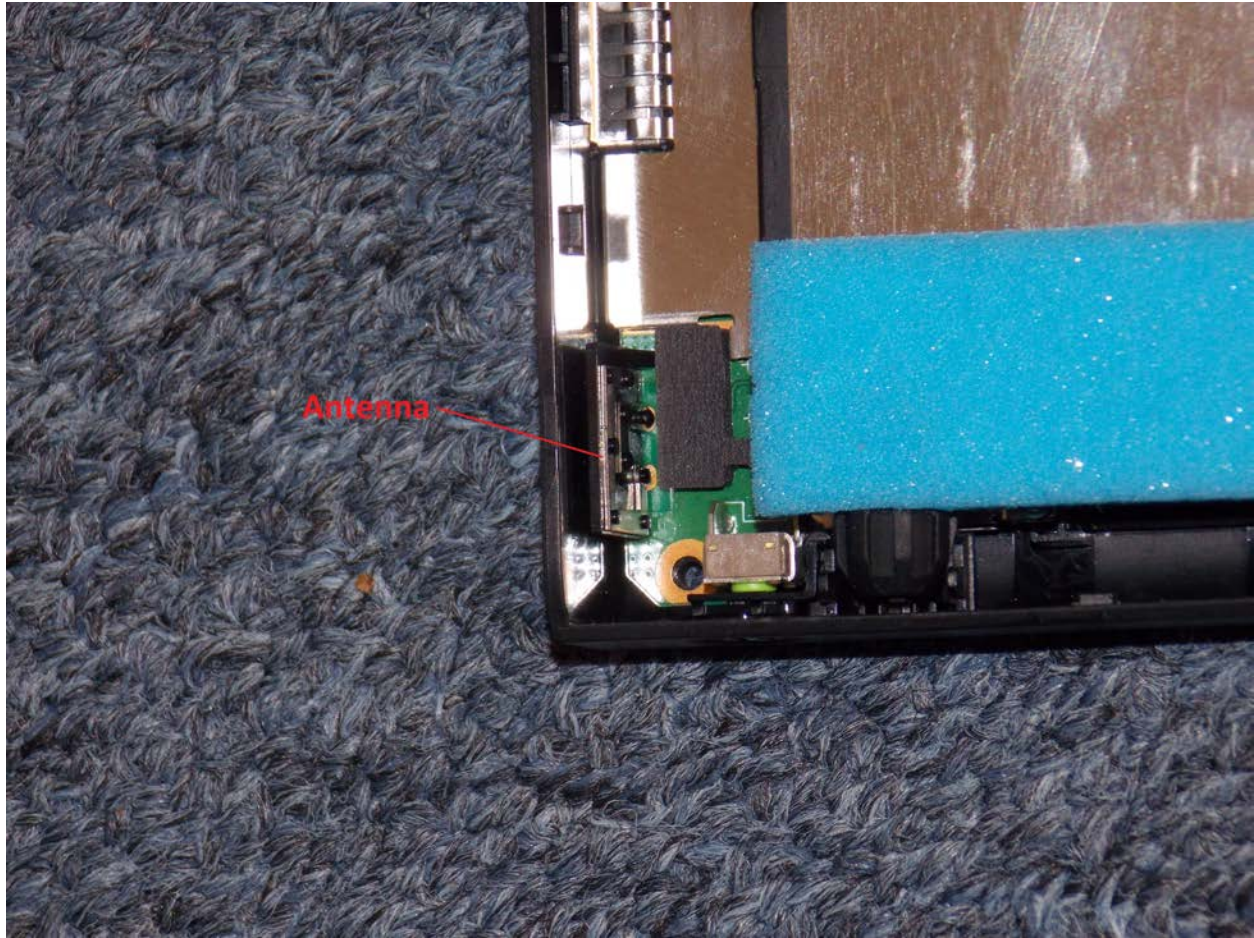


Seeqate Gemini DVT sample  
engineering sample T1 33521 FW:4.0.0.045  
SN: NA302068 PIC: 1603 FW: DV204  
Misc: 001079FE31E9 PIC: 1788 FW: DV205\_P2  
PCBA: V1 R0 ASMEDIA FW: 78\_0A  
Tooling: Top-TZ, Bottom-T1  
DVT AVL 2 /HDD Capacity: 2 TB  
Product of China (HDD)  
Assembled in China

11  
001079FE31E9  
NA302068

NEX 250150  
ITEM # 2  
2 / 4 / 2014

**Back of Device**



**Antenna**